Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/539,461	PARRUCK ET AL.	
Examiner	Art Unit	
Thien D. Tran	2665	

Thien D. Tran_

SEARCHED						
Class	Subclass	Date	Examiner			
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (USPGPUB, USPAT, USOCR, EPO, DERWENT) 370/466, 538, 539.	9/26/2005	тт		
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